

Notice of References Cited

Application/Control No.

10/693,416

Applicant(s)/Patent Under
Reexamination
YOON ET AL.

Examiner

Venkatesh Haliyur

Art Unit

2616

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-6,807,156 | 10-2004 | Veres et al. | 370/252 |
| * | B | US-5,872,771 | 02-1999 | Park et al. | 370/252 |
| * | C | US-6,882,930 | 04-2005 | Trayford et al. | 701/117 |
| * | D | US-2003/0039212 | 02-2003 | Lloyd et al. | 370/235 |
| * | E | US-6,978,223 | 12-2005 | Milliken, Walter Clark | 702/182 |
| * | F | US-2002/0114280 | 08-2002 | Yi et al. | 370/235 |
| * | G | US-7,062,264 | 06-2006 | Ko et al. | 455/423 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.